

Day : Tuesday  
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# PALM INTRANET

## Inventor Name Search Result

Your Search was:

Last Name = GHINOVKER

First Name = MARK

Application#	Patent#	Status	Date Filed	Title	Inventor Name 29
<a href="#"><u>60546546</u></a>	Not Issued	020	02/20/2004	APPARATUS AND METHODS FOR DETERMINING OVERLAY AND USES OF SAME	GHINOVKER, MARK
<a href="#"><u>60506281</u></a>	Not Issued	020	09/26/2003	STRUCTURES AND METHODS FOR OVERLAY METROLOGY	GHINOVKER, MARK
<a href="#"><u>60484627</u></a>	Not Issued	020	07/02/2003	APPARATUS AND METHODS FOR PROVIDING IN-CHIP MICROTARGETS FOR METROLOGY OR INSPECTION	GHINOVKER, MARK
<a href="#"><u>60456681</u></a>	Not Issued	020	03/19/2003	USE OF OVERLAY DIAGNOSTICS FOR ENHANCED AUTOMATIC PROCESS CONTROL	GHINOVKER, MARK
<a href="#"><u>60419786</u></a>	Not Issued	020	10/17/2002	OVERLAY METROLOGY	GHINOVKER, MARK
<a href="#"><u>60395847</u></a>	Not Issued	159	07/11/2002	USE OF OVERLAY DIAGNOSTICS FOR ENHANCED AUTOMATIC PROCESS CONTROL	GHINOVKER, MARK
<a href="#"><u>60386285</u></a>	Not Issued	159	06/05/2002	USE OF OVERLAY DIAGNOSTICS FOR ENHANCED AUTOMATIC PROCESS CONTROL	GHINOVKER, MARK
<a href="#"><u>60357390</u></a>	Not Issued	159	02/15/2002	OVERLAY METROLOGY	GHINOVKER, MARK
<a href="#"><u>60301763</u></a>	Not Issued	159	06/27/2001	OVERLAY MARKS, METHOD OF OVERLAY MARK DESIGNED AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK

<u>60301613</u>	Not Issued	159	06/27/2001	OVERLAY MARKS, METHOD OF OVERLAY MARK DESIGNED AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK
<u>60301591</u>	Not Issued	159	06/27/2001	OVERLAY MARKS, METHOD OF OVERLAY MARK DESIGNED AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK
<u>60301484</u>	Not Issued	159	06/27/2001	OVERLAY MARKS, METHOD OF OVERLAY MARK DESIGNED AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK
<u>10785821</u>	Not Issued	019	02/23/2004	APPARATUS AND METHODS FOR DETECTING OVERLAY ERRORS USING SCATTEROMETRY	GHINOVKER, MARK
<u>10785732</u>	Not Issued	019	02/23/2004	APPARATUS AND METHODS FOR DETECTING OVERLAY ERRORS USING SCATTEROMETRY	GHINOVKER, MARK
<u>10785731</u>	Not Issued	019	02/23/2004	APPARATUS AND METHODS FOR DETECTING OVERLAY ERRORS USING SCATTEROMETRY	GHINOVKER, MARK
<u>10785723</u>	Not Issued	019	02/23/2004	APPARATUS AND METHODS FOR DETECTING OVERLAY ERRORS USING SCATTEROMETRY	GHINOVKER, MARK
<u>10785430</u>	Not Issued	019	02/23/2004	APPARATUS AND METHODS FOR DETECTING OVERLAY ERRORS USING SCATTEROMETRY	GHINOVKER, MARK
<u>10785396</u>	Not Issued	019	02/23/2004	APPARATUS AND METHODS FOR DETECTING OVERLAY ERRORS USING SCATTEROMETRY	GHINOVKER, MARK
<u>10785395</u>	Not Issued	019	02/23/2004	APPARATUS AND METHODS FOR DETECTING OVERLAY ERRORS	GHINOVKER, MARK
<u>10729838</u>	Not Issued	018	12/05/2003	APPARATUS AND METHOD FOR DETECTING OVERLAY ERRORS USING SCATTEROMETRY	GHINOVKER, MARK

<u>10438963</u>	Not Issued	030	05/14/2003	USE OF OVERLAY DIAGNOSTICS FOR ENHANCED AUTOMATIC PROCESS CONTROL	GHINOVKER, MARK
<u>10438962</u>	Not Issued	030	05/14/2003	USE OF OVERLAY DIAGNOSTICS FOR ENHANCED AUTOMATIC PROCESS CONTROL	GHINOVKER, MARK
<u>10423827</u>	Not Issued	030	04/25/2003	METHOD AND MARK FOR METROLOGY OF PHASE ERRORS ON PHASE SHIFT MASKS	GHINOVKER, MARK
<u>10367124</u>	Not Issued	020	02/13/2003	OVERLAY METROLOGY AND CONTROL METHOD	GHINOVKER, MARK
<u>10186324</u>	Not Issued	030	06/26/2002	OVERLAY MARKS, METHODS OF OVERLAY MARK DESIGN AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK
<u>10185737</u>	Not Issued	071	06/26/2002	OVERLAY MARKS, METHODS OF OVERLAY MARK DESIGN AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK
<u>10184026</u>	Not Issued	030	06/26/2002	OVERLAY MARKS, METHODS OF OVERLAY MARK DESIGN AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK
<u>10184013</u>	Not Issued	030	06/26/2002	OVERLAY MARKS, METHODS OF OVERLAY MARK DESIGN AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK
<u>09894987</u>	Not Issued	030	06/27/2001	OVERLAY MARKS, METHODS OF OVERLAY MARK DESIGN AND METHODS OF OVERLAY MEASUREMENTS	GHINOVKER, MARK

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